PSMN5R5-60YS

N-channel LFPAK 60 V, 5.2 m Ω standard level FET

Rev. 02 — 24 December 2009

Product data sheet

1. Product profile

1.1 General description

Standard level N-channel MOSFET in LFPAK package qualified to 175 °C. This product is designed and qualified for use in a wide range of industrial, communications and domestic equipment.

1.2 Features and benefits

- Advanced TrenchMOS provides low RDSon and low gate charge
- High efficiency in switching power converters
- Improved mechanical and thermal characteristics
- LFPAK provides maximum power density in a Power SO8 package

1.3 Applications

- DC-to-DC converters
- Lithium-ion battery protection
- Load switching

- Motor control
- Server power supplies

1.4 Quick reference data

Table 1. Quick reference

| Symbol | Parameter | Conditions | | Min | Тур | Max | Unit |
|----------------------|--|---|------------|-----|------|-----|------|
| V_{DS} | drain-source voltage | $T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}$ | | - | - | 60 | V |
| I_D | drain current | T _{mb} = 25 °C; see <u>Figure 1</u> | <u>[1]</u> | - | - | 100 | Α |
| P _{tot} | total power dissipation | T _{mb} = 25 °C; see <u>Figure 2</u> | | - | - | 130 | W |
| Tj | junction temperature | | | -55 | - | 175 | °C |
| Avalanc | he ruggedness | | | | | | |
| E _{DS(AL)S} | non-repetitive drain-source avalanche energy | V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; I_D = 100 A; V_{sup} ≤ 60 V; R_{GS} = 50 Ω; unclamped | | - | - | 170 | mJ |
| Dynamic | characteristics | | | | | | |
| Q_{GD} | gate-drain charge | $V_{GS} = 10 \text{ V}; I_D = 75 \text{ A};$ | | - | 11.2 | - | nC |
| Q _{G(tot)} | total gate charge | V _{DS} = 30 V; see <u>Figure 14</u> and <u>15</u> | | - | 56 | - | nC |



Table 1. Quick reference ... continued

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|--|----------------|---|-----|-----|-----|------|
| Static cl | haracteristics | | | | | |
| R _{DSon} drain-source on-state resistance | | $V_{GS} = 10 \text{ V}; I_D = 15 \text{ A};$ $T_j = 100 \text{ °C}; \text{ see } \frac{\text{Figure } 12}{}$ | - | - | 8.3 | mΩ |
| | | $V_{GS} = 10 \text{ V}; I_D = 15 \text{ A};$ $T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure } 13}{\text{ c}}$ | - | 3.6 | 5.2 | mΩ |

^[1] Continuous current is limited by package.

2. Pinning information

Table 2. Pinning information

| Pin | Symbol | Description | Simplified outline | Graphic symbol |
|-----|--------|-----------------------------------|--------------------|----------------|
| 1 | S | source | | |
| 2 | S | source | mb | D |
| 3 | S | source | | <u>。</u> (民本) |
| 4 | G | gate | 9 | |
| mb | D | mounting base; connected to drain | 1 2 3 4 | mbb076 Ś |
| | | | SOT669 (LFPAK) | |

3. Ordering information

Table 3. Ordering information

| Type number | Package | | |
|--------------|---------|---|---------|
| | Name | Description | Version |
| PSMN5R5-60YS | LFPAK | plastic single-ended surface-mounted package (LFPAK); 4 leads | SOT669 |

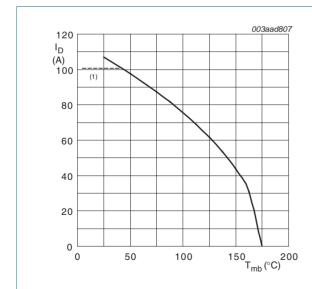
4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

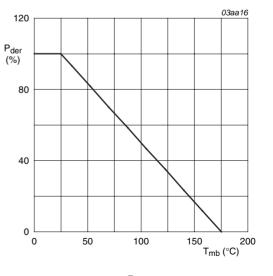
| Symbol | Parameter | Conditions | | Min | Max | Unit |
|----------------------|--|---|------------|-----|-----|------|
| V_{DS} | drain-source voltage | T _j ≥ 25 °C; T _j ≤ 175 °C | | - | 60 | V |
| V_{DGR} | drain-gate voltage | $T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}; R_{GS} = 20 \text{ k}\Omega$ | | - | 60 | V |
| V_{GS} | gate-source voltage | | | -20 | 20 | V |
| I _D | drain current | T _{mb} = 100 °C; see <u>Figure 1</u> | | - | 74 | Α |
| | | T _{mb} = 25 °C; see <u>Figure 1</u> | <u>[1]</u> | - | 100 | Α |
| I_{DM} | peak drain current | t _p ≤ 10 μs; pulsed; T _{mb} = 25 °C; see <u>Figure 3</u> | | - | 418 | Α |
| P _{tot} | total power dissipation | T _{mb} = 25 °C; see <u>Figure 2</u> | | - | 130 | W |
| T _{stg} | storage temperature | | | -55 | 175 | °C |
| Tj | junction temperature | | | -55 | 175 | °C |
| $T_{sld(M)}$ | peak soldering temperature | | | - | 260 | °C |
| Source-dr | ain diode | | | | | |
| I _S | source current | T _{mb} = 25 °C; | <u>[1]</u> | - | 100 | Α |
| I _{SM} | peak source current | t _p ≤ 10 μs; pulsed; T _{mb} = 25 °C | | - | 418 | Α |
| Avalanche | ruggedness | | | | | |
| E _{DS(AL)S} | non-repetitive drain-source avalanche energy | V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; I_D = 100 A; V_{sup} ≤ 60 V; R_{GS} = 50 Ω; unclamped | | - | 170 | mJ |

[1] Continuous current is limited by package.



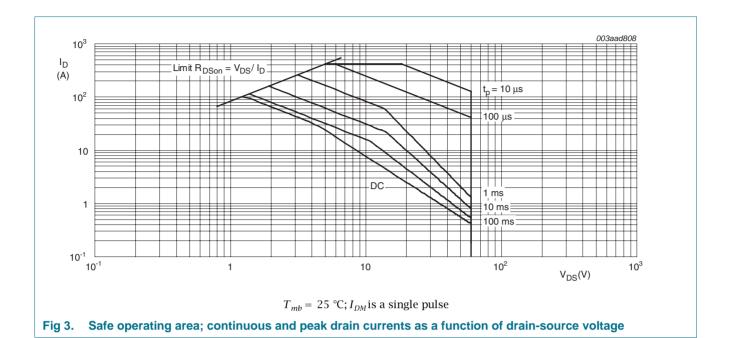
 $V_{\it GS} \ge 10$ V; (1) capped at 100 A due to package Fig 1. Continuous drain current as a function of

mounting base temperature



 $P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$

Fig 2. Normalized total power dissipation as a function of mounting base temperature



4 of 15

5. Thermal characteristics

Table 5. Thermal characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|-----------------------|---|--------------|-----|-----|-----|------|
| $R_{th(j\text{-}mb)}$ | thermal resistance from junction to mounting base | see Figure 4 | - | 0.5 | 1.1 | K/W |

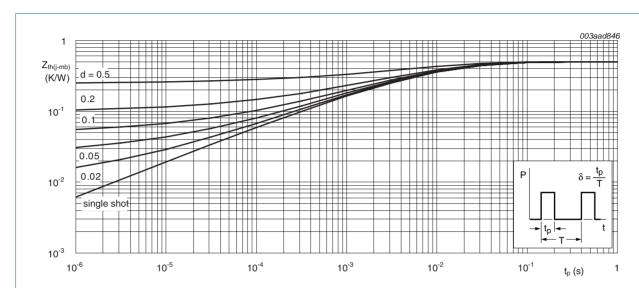


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration; typical values

6. Characteristics

Table 6. Characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|------------------------|--------------------------------------|--|--------|------|----------|-------|
| • | racteristics | Conditions | 141111 | ıур | IVIAA | Ollit |
| | drain-source | $I_D = 250 \mu\text{A}; V_{GS} = 0 V; T_j = -55 ^{\circ}\text{C}$ | 54 | _ | _ | V |
| $V_{(BR)DSS}$ | breakdown voltage | $I_D = 250 \mu\text{A}, \text{V}_{GS} = 0 \text{V}, \text{T}_j = 53 \text{C}$ $I_D = 250 \mu\text{A}; \text{V}_{GS} = 0 \text{V}; \text{T}_i = 25 \text{°C}$ | 60 | - | - | V |
| $V_{GS(th)}$ | gate-source threshold | $I_D = 250 \mu\text{A}, \text{V}_{GS} = 0 \text{V}, \text{I}_J = 25 \text{C}$ $I_D = 1 \text{mA}; \text{V}_{DS} = \text{V}_{GS}; \text{T}_i = 25 \text{°C};$ | 2 | 3 | 4 | V |
| | voltage | see Figure 10 and 11 | 2 | | - | |
| V_{GSth} | | $I_D = 1 \text{ mA}$; $V_{DS} = V_{GS}$; $T_j = -55 \text{ °C}$; see Figure 11 | - | - | 4.6 | V |
| | | $I_D = 1$ mA; $V_{DS} = V_{GS}$; $T_j = 175$ °C; see Figure 11 | 0.95 | - | - | V |
| I _{DSS} | drain leakage current | $V_{DS} = 60 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$ | - | 0.05 | 5 | μΑ |
| | | $V_{DS} = 60 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 125 ^{\circ}\text{C}$ | - | - | 100 | μΑ |
| I _{GSS} | gate leakage current | $V_{GS} = 20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$ | - | 2 | 100 | nA |
| | | $V_{GS} = -20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$ | - | 2 | 100 | nA |
| R _{DSon} | drain-source on-state resistance | $V_{GS} = 10 \text{ V}; I_D = 15 \text{ A}; T_j = 175 ^{\circ}\text{C};$ see Figure 12 | - | 7.6 | 12 | mΩ |
| | | $V_{GS} = 10 \text{ V}; I_D = 15 \text{ A}; T_j = 100 \text{ °C};$ see Figure 12 | - | - | 8.3 | mΩ |
| | | $V_{GS} = 10 \text{ V}; I_D = 15 \text{ A}; T_j = 25 ^{\circ}\text{C};$ see Figure 13 | - | 3.6 | 5.2 | mΩ |
| R _G | gate resistance | f = 1 MHz | - | 0.7 | - | Ω |
| | characteristics | | | | | |
| Q _{G(tot)} | total gate charge | I _D = 75 A; V _{DS} = 30 V; V _{GS} = 10 V; see Figure 14 and 15 | - | 56 | - | nC |
| | | $I_D = 0 \text{ A; } V_{DS} = 0 \text{ V; } V_{GS} = 10 \text{ V}$ | - | 47.5 | - | nC |
| Q_{GS} | gate-source charge | $I_D = 75 \text{ A}; V_{DS} = 30 \text{ V}; V_{GS} = 10 \text{ V};$ see Figure 14 and 15 | - | 18.7 | - | nC |
| Q _{GS(th)} | pre-threshold gate-source charge | $I_D = 75 \text{ A}; V_{DS} = 30 \text{ V}; V_{GS} = 10 \text{ V};$ see Figure 14 | - | 10.3 | - | nC |
| Q _{GS(th-pl)} | post-threshold gate-source charge | | - | 8.4 | - | nC |
| Q_{GD} | gate-drain charge | I _D = 75 A; V _{DS} = 30 V; V _{GS} = 10 V; see <u>Figure 14</u> and <u>15</u> | - | 11.2 | - | nC |
| V _{GS(pI)} | gate-source plateau voltage | V _{DS} = 30 V; see <u>Figure 14</u> and <u>15</u> | - | 4.9 | - | V |
| C _{iss} | input capacitance | $V_{DS} = 30 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}; T_i = 25 °C;$ | - | 3501 | - | pF |
| Coss | output capacitance | see Figure 16 | - | 457 | - | pF |
| C _{rss} | reverse transfer | | - | 240 | - | pF |
| | capacitance | | | | | |
| t _{d(on)} | turn-on delay time | $V_{DS} = 30 \text{ V}; R_L = 0.4 \Omega; V_{GS} = 10 \text{ V};$ | - | 23 | - | ns |
| t _r | rise time | $R_{G(ext)} = 4.7 \Omega$ | - | 24 | - | ns |
| $t_{d(off)}$ | turn-off delay time | | - | 44 | - | ns |
| t_{f} | fall time | | - | 14 | - | ns |

Table 6. Characteristics ... continued

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|-----------------|-----------------------|--|-----|-----|-----|------|
| Source-dr | ain diode | | | | | |
| V _{SD} | source-drain voltage | $I_S = 15 \text{ A}$; $V_{GS} = 0 \text{ V}$; $T_j = 25 \text{ °C}$; see <u>Figure 17</u> | - | 8.0 | 1.2 | V |
| t _{rr} | reverse recovery time | $I_S = 25 \text{ A}$; $dI_S/dt = -100 \text{ A/}\mu\text{s}$; $V_{GS} = 0 \text{ V}$; | - | 43 | - | ns |
| Q _r | recovered charge | $V_{DS} = 30 \text{ V}$ | - | 58 | - | nC |

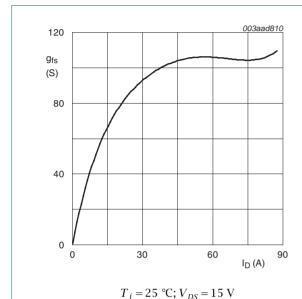
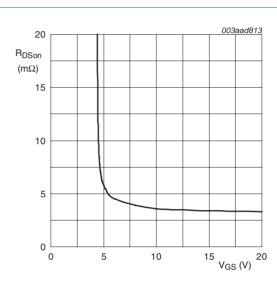


Fig 5. Forward transconductance as a function of drain current; typical values



 $T_i = 25$ °C; $I_D = 25$ A

Fig 6. Drain-source on-state resistance as a function of gate-source voltage; typical values

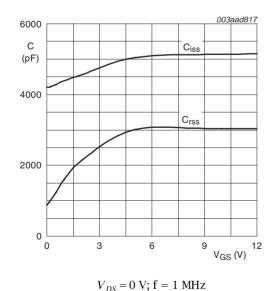
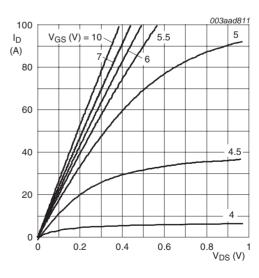
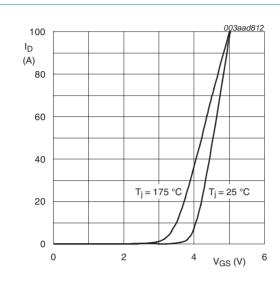


Fig 7. Input and reverse transfer capacitances as a function of gate-source voltage, typical values



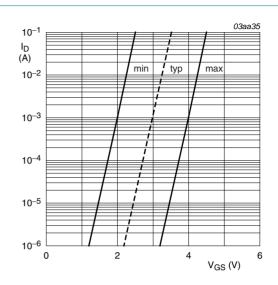
 $T_i = 25 \,^{\circ}C$

Fig 8. Output characteristics: drain current as a function of drain-source voltage; typical values



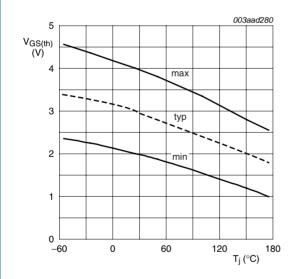
 $V_{DS} > I_D \times R_{DSon}$

Fig 9. Transfer characteristics: drain current as a function of gate-source voltage; typical values



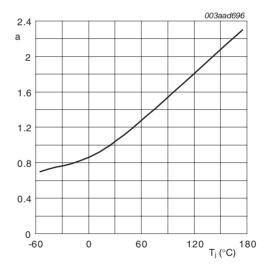
$$T_{j} = 25 \,^{\circ}C; V_{DS} = 5V$$

Fig 10. Sub-threshold drain current as a function of gate-source voltage



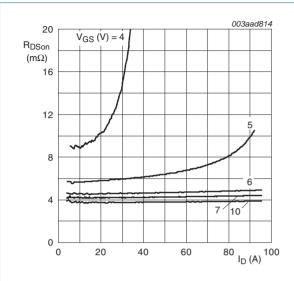
 $I_D = 1 \, mA; V_{DS} = V_{GS}$

Fig 11. Gate-source threshold voltage as a function of junction temperature



$$a = \frac{R_{DSon}}{R_{DSon(25^{\circ}C)}}$$

Fig 12. Normalized drain-source on-state resistance factor as a function of junction temperature.



V_{DS}

V_{GS(pl)}

V_{GS(th)}

V_{GS}

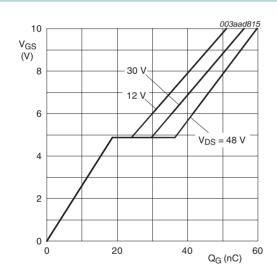
Q_{GS1}
Q_{GS2}
Q_{G(tot)}

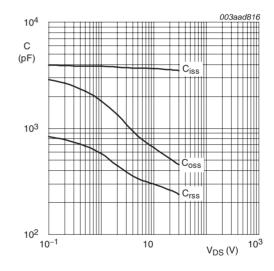
003aaa508

Fig 13. Drain-source on-state resistance as a function of drain current; typical values

 $T_j = 25 \,^{\circ}C$

Fig 14. Gate charge waveform definitions





 $T_J = 25$ °C; $I_D = 75$ A

Fig 15. Gate-source voltage as a function of gate charge; typical values



 $V_{GS} = 0 \text{ V; } f = 1 \text{ MHz}$

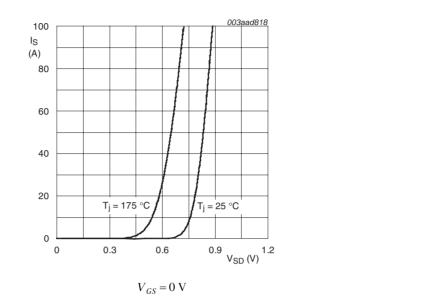
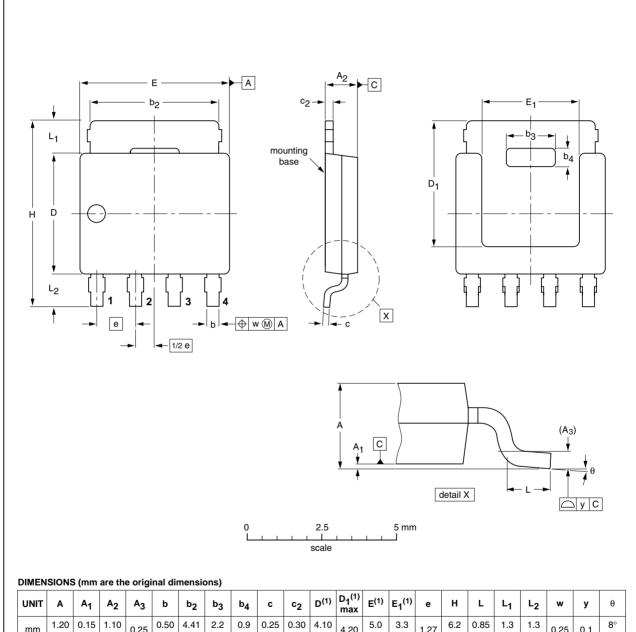


Fig 17. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values

Package outline

Plastic single-ended surface-mounted package (LFPAK); 4 leads

SOT669



| | UNIT | Α | A ₁ | A ₂ | A ₃ | b | b ₂ | b ₃ | b ₄ | С | c ₂ | D ⁽¹⁾ | D ₁ ⁽¹⁾ max | E ⁽¹⁾ | E ₁ ⁽¹⁾ | е | Н | L | L ₁ | L ₂ | w | у | θ |
|---|------|--------------|----------------|----------------|----------------|--------------|----------------|----------------|----------------|--------------|----------------|------------------|--------------------------------------|------------------|-------------------------------|------|------------|--------------|----------------|----------------|------|-----|----|
| | mm | 1.20 1.01 | 0.15 0.00 | 1.10 0.95 | 0.25 | 0.50 0.35 | 4.41 3.62 | 2.2 2.0 | 0.9 0.7 | 0.25 0.19 | l . | 4.10 3.80 | 4.20 | 5.0 4.8 | 3.3 3.1 | 1.27 | 6.2 5.8 | 0.85 0.40 | 1.3 0.8 | 1.3 0.8 | 0.25 | 0.1 | 8° |
| L | | 1.01 | 0.00 | 0.00 | | 0.00 | 0.02 | 2.0 | 0.7 | 0.10 | 0.2 1 | 0.00 | | 1.0 | 0.1 | | 0.0 | 0.10 | 0.0 | 0.0 | | | · |

Note

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

| OUTLINE | | EUROPEAN | ISSUE DATE | | | |
|---------|-----|----------|------------|--|------------|---------------------------------|
| VERSION | IEC | JEDEC | JEITA | | PROJECTION | ISSUE DATE |
| SOT669 | | MO-235 | | | | 04-10-13 06-03-16 |

Fig 18. Package outline SOT669 (LFPAK)

PSMN5R5-60YS

N-channel LFPAK 60 V, 5.2 m Ω standard level FET

Revision history

Table 7. **Revision history**

| Document ID | Release date | Data sheet status | Change notice | Supersedes | | | |
|----------------|---|----------------------|---------------|----------------|--|--|--|
| PSMN5R5-60YS_2 | 20091224 | Product data sheet | - | PSMN5R5-60YS_1 | | | |
| Modifications: | fications: • Status changed from objective to product. | | | | | | |
| PSMN5R5-60YS_1 | 20091201 | Objective data sheet | - | - | | | |

9. Legal information

9.1 Data sheet status

| Document status[1][2] | Product status[3] | Definition |
|--------------------------------|-------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification | This document contains data from the preliminary specification. |
| Product [short] data sheet | Production | This document contains the product specification. |

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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PSMN5R5-60YS

N-channel LFPAK 60 V, 5.2 m Ω standard level FET

11. Contents

| 1 | Product profile |
|-----|--------------------------|
| 1.1 | General description |
| 1.2 | Features and benefits1 |
| 1.3 | Applications1 |
| 1.4 | Quick reference data1 |
| 2 | Pinning information2 |
| 3 | Ordering information2 |
| 4 | Limiting values3 |
| 5 | Thermal characteristics5 |
| 6 | Characteristics6 |
| 7 | Package outline |
| 8 | Revision history12 |
| 9 | Legal information13 |
| 9.1 | Data sheet status |
| 9.2 | Definitions |
| 9.3 | Disclaimers |
| 9.4 | Trademarks14 |
| 10 | Contact information |

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